SCCS023A - MAY 1994 - REVISED OCTOBER 2001

 Function, Pinout, and Drive Compatible With FCT and F Logic 	SN74FCT377T Q OR SO PACKAGE (TOP VIEW)
 Reduced V_{OH} (Typically = 3.3 V) Versions of Equivalent FCT Functions 	$ \overline{CE} \begin{bmatrix} 1 & 20 \end{bmatrix} V_{CC} \\ O_0 \begin{bmatrix} 2 & 19 \end{bmatrix} O_7 $
 Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics 	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$
 I_{off} Supports Partial-Power-Down Mode Operation 	$O_2 \begin{bmatrix} 6 & 15 \\ 0_5 \end{bmatrix} O_5 \\ D_2 \begin{bmatrix} 7 & 14 \end{bmatrix} D_5$
 Matched Rise and Fall Times 	D ₃ [] 8 13 [] D ₄
 ESD Protection Exceeds JESD 22 2000-V Human-Body Model (A114-A) 200-V Machine Model (A115-A) 1000-V Charged-Device Model (C101) 	O ₃ [] 9 12 [] O ₄ GND [] 10 11] CP SN54FCT377T L PACKAGE
 Fully Compatible With TTL Input and Output Logic Levels 	(TOP VIEW)
 Clock Enable for Address and Data Synchronization Application 	
 Eight Edge-Triggered D-Type Flip-Flops CY54FCT377T 32-mA Output Sink Current 12-mA Output Source Current CY74FCT377T 	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$
 – 64-mA Output Sink Current – 32-mA Output Source Current 	⁶ ⁶ ⁹ ⁰ ⁰

description

The 'FCT377T devices have eight triggered D-type flip-flops with individual data (D) inputs. The common buffered clock (CP) inputs load all flip-flops simultaneously when the clock-enable (\overline{CE}) input is low. The register is fully edge triggered. The state of each D input at one setup time before the low-to-high clock transition is transferred to the corresponding flip-flop output (O). \overline{CE} must be stable only one setup time prior to the low-to-high clock transition for predictable operation.

These devices are fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 2001, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

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TA	PAC	KAGE [†]	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING						
	QSOP – Q	Tape and reel	5.2	CY74FCT377CTQCT	FCT377C						
	SOIC – SO	Tube	5.2	CY74FCT377CTSOC	FCT377C						
	3010 - 30	Tape and reel	5.2	CY74FCT377CTSOCT	1013/70						
–40°C to 85°C	QSOP – Q	Tape and reel	7.2	CY74FCT377ATQCT	FCT377A						
	SOIC – SO	Tube	7.2	CY74FCT377ATSOC	FCT377A						
	3010 - 30	Tape and reel	7.2	CY74FCT377ATSOCT	FCISITA						
	QSOP – Q	Tape and reel	13	CY74FCT377TQCT	FCT377						
–55°C to 125°C	LCC – L	Tube	5.5	CY54FCT377CTLMB							
-55 C 10 125 C	L00 - L	Tube	8.3	CY54FCT377ATLMB							

ORDERING INFORMATION

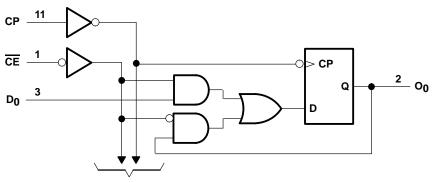
[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

	INPUTS		OUTPUT	OPERATING
СР	CE	D	0	MODE
↑	I	h	н	Load 1
\uparrow	I	Ι	L	Load 0
↑ X	h H	X X	No change	Hold

H = High logic level, h = High logic level one setup time prior to the low-to-high clock transition, L = Low logic level, I = Low logic level one setup time prior to the low-to-high clock transition, X = Don't care, \uparrow = Low-to-high clock transition

logic diagram



To Seven Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range to ground potential	–0.5 V to 7 V
DC input voltage range	–0.5 V to 7 V
DC output voltage range	–0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ_{JA} (see Note 1): Q package	68°C/W
SO package	58°C/W
Ambient temperature range with power applied, T _A	65°C to 135°C
Storage temperature range, T _{stg}	. –65°C to 150°C

⁺ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 2)

		CY	54FCT37	7T	CY7	74FCT37	'7T	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
ЮН	High-level output current			-12			-32	mA
IOL	Low-level output current			32			64	mA
TA	Operating free-air temperature	-55		125	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.



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		CY	54FCT37	7T	CY	74FCT37	7T		
PARAMETER	TEST CONDITIO	NS	MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	UNIT
	$V_{CC} = 4.5 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$			-0.7	-1.2				V
VIK	$V_{CC} = 4.75 \text{ V}, I_{IN} = -18 \text{ mA}$						-0.7	-1.2	v
	$V_{CC} = 4.5 V$, $I_{OH} = -12 mA$		2.4	3.3					
Voн	$I_{OH} = -32 \text{ mA}$					2			V
	$V_{CC} = 4.75 \text{ V}$ $I_{OH} = -15 \text{ mA}$					2.4	3.3		
) (V _{CC} = 4.5 V, I _{OL} = 32 mA			0.3	0.55				V
VOL	V _{CC} = 4.75 V, I _{OL} = 64 mA						0.3	0.55	v
V _{hys}	All inputs			0.2			0.2		V
	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = V_{CC}$				5				
łı	$V_{CC} = 5.25 \text{ V}, V_{IN} = V_{CC}$							5	μA
i	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 2.7 \text{ V}$				±1				μA
lΗ	$V_{CC} = 5.25 \text{ V}, V_{IN} = 2.7 \text{ V}$							±1	μΑ
1	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 0.5 \text{ V}$				±1				μA
ΙL	$V_{CC} = 5.25 \text{ V}, V_{IN} = 0.5 \text{ V}$							±1	μА
· +	$V_{CC} = 5.5 \text{ V}, \qquad V_{OUT} = 0 \text{ V}$		-60	-120	-225				mA
los‡	V _{CC} = 5.25 V, V _{OUT} = 0 V					-60	-120	-225	ША
l _{off}	V _{CC} = 0 V, V _{OUT} = 4.5 V				±1			±1	μA
	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} \leq 0.2 \text{ V},$	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2				mA
lcc	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} \leq 0.2 \text{ V},$						0.1	0.2	ШA
	$V_{CC} = 5.5 \text{ V}, V_{IN} = 3.4 \text{ V}\$, f_1 = 0, C$			0.5	2				mA
∆ICC	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3.4 \text{ V}\$, f_1 = 0,$	Outputs open					0.5	2	ШA

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] Typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

* Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

§ Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

		TEAT CONDITIO	20	CY	54FCT37	'7T	CY	74FCT37	7T	
PARAMETER		TEST CONDITIO	NS	MIN	түр†	MAX	MIN	түр†	MAX	UNIT
1005¶		Itputs open, g at 50% duty cycle IN $^{≥}$ V _{CC} − 0.2 V	, $\overline{CE} = GND$,		0.06	0.12				mA/
ICCD		Outputs open, g at 50% duty cycle IN ≥ V _{CC} – 0.2 V					0.06	0.12	MHz	
		One bit switching at f ₁ = 5 MHz at	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$		0.7	1.4				
	$V_{CC} = 5.5 V,$ Outputs open,	50% duty cycle	V_{IN} = 3.4 V or GND		1.2	3.4				
		Eight bits switching at f ₁ = 2.5 MHz at	$\begin{array}{l} V_{IN} \leq 0.2 \text{ V or} \\ V_{IN} \geq V_{CC} - 0.2 \text{ V} \end{array}$		1.6	3.2				
ı#		50% duty cycle	V_{IN} = 3.4 V or GND		3.9	12.2				4
IC#		One bit switching at $f_1 = 5 MHz$ at	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$					0.7	1.4	mA
	V _{CC} = 5.25 V, Outputs open,	50% duty cycle	V_{IN} = 3.4 V or GND					1.2	3.4	
<u>fo</u> =	<u>f</u> 0 = 10 MHz, CE = GND	Eight bits switching at	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array} \end{array} \label{eq:VIN}$					1.6	3.2	
		f ₁ = 2.5 MHz at 50% duty cycle	V_{IN} = 3.4 V or GND					3.9	12.2	
Ci		-			5	10		5	10	pF
Co					9	12		9	12	pF

[†] Typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

 \P This parameter is derived for use in total power-supply calculations.

[#]IC = ICC + Δ ICC × D_H × N_T + I_{CCD} (f₀/2 + f₁ × N₁)

- Where:
- = Total supply current IC
- ICC = Power-supply current with CMOS input levels
- ΔI_{CC} = Power-supply current for a TTL high input (V_{IN} = 3.4 V)

 D_H = Duty cycle for TTL inputs high NT = Number of TTL inputs at D_H

- I_{CCD} = Dynamic current caused by an input transition pair (HLH or LHL)
- = Clock frequency for registered devices, otherwise zero fo
- f₁ = Input signal frequency
- = Number of inputs changing at f1 N₁

All currents are in milliamperes and all frequencies are in megahertz.

Il Values for these conditions are examples of the I_{CC} formula.



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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			CY54FC1 CY54FC1	-	CY74FC CY74FCT CY74FCT	377AT	UNIT	
			MIN	MAX	MIN	MAX		
tw	Pulse duration, CP high or low †		7		6		ns	
4	Satur time, high or low	Data before CP↑			2			
t _{su}	Setup time, high or low	CE before CP↑	3.5		3.5	ns		
.	Hold time, high or low	Data after CP↑	1.5		1.5			
th	Hold time, high or low	CE after CP↑	1.5		1.5		ns	

[†] With one data channel switching, $t_{W(L)} = t_{W(H)} = 4$ ns and $t_{f} = t_{f} = 1$ ns.

switching characteristics over operating free-air temperature range (see Figure 1)

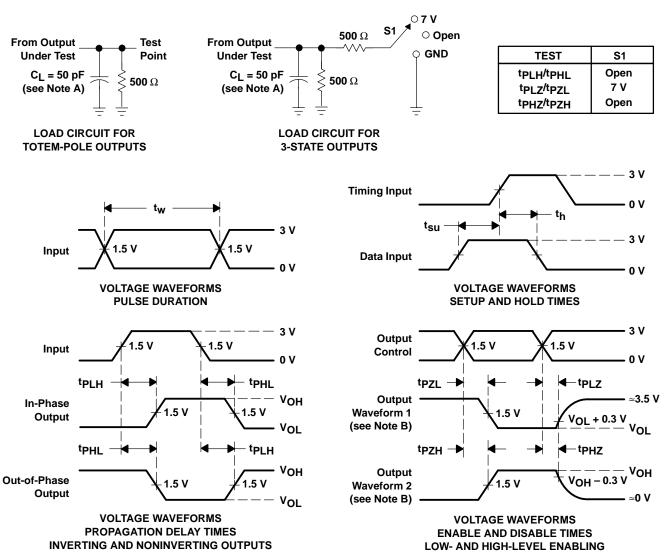
PARAMETER	FROM	то	CY54FC1	[377AT	CY54FC1	UNIT	
FARAWETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
^t PLH	СР	0	2	8.3	2	5.5	20
^t PHL	CF	0	2	8.3	2	5.5	ns

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	то		CY74FCT377T		CY74FCT377AT		CY74FCT377CT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	СР	0	2	13	2	7.2	2	5.2	200
^t PHL	CP	0	2	13	2	7.2	2	5.2	ns



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. C_L includes probe and jig capacitance.

 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



24-May-2007

PACKAGING INFORMATION

TEXAS *RUMENTS*

www.ti.com

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	n MSL Peak Temp ⁽³⁾
5962-9221902M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9221903M2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
CY54FCT377CTLMB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
CY74FCT377ATQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377ATQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377ATQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377ATSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377ATSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377ATSOCG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377ATSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377ATSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377ATSOCTG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377CTSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTSOCG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377CTSOCTG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT377TQCT	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377TQCTE4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT377TQCTG4	ACTIVE	SSOP/ QSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

(1) The marketing status values are defined as follows:
 ACTIVE: Product device recommended for new designs.
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 NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

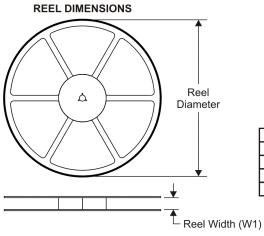
⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

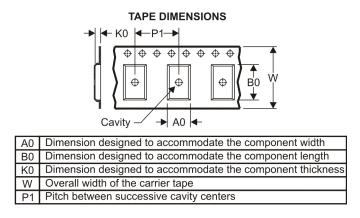
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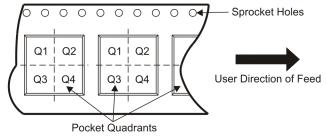
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT377ATQCT	SSOP/ QSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT377ATSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CY74FCT377CTQCT	SSOP/ QSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT377CTSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CY74FCT377TQCT	SSOP/ QSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT377ATQCT	SSOP/QSOP	DBQ	20	2500	346.0	346.0	33.0
CY74FCT377ATSOCT	SOIC	DW	20	2000	346.0	346.0	41.0
CY74FCT377CTQCT	SSOP/QSOP	DBQ	20	2500	346.0	346.0	33.0
CY74FCT377CTSOCT	SOIC	DW	20	2000	346.0	346.0	41.0
CY74FCT377TQCT	SSOP/QSOP	DBQ	20	2500	346.0	346.0	33.0

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